

**Notice of References Cited**

Application/Control No.

10/023,010

Applicant(s)/Patent Under  
Reexamination  
HADFIELD ET AL.

Examiner

Doug Hutton

Art Unit

2176

Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,658,626	12-2003	Aiken, Alexander	715/530
*	B	US-6,560,620	05-2003	Ching, Philip Waisin	707/203
*	C	US-6,449,624	09-2002	Hammack et al.	707/203
*	D	US-6,584,466	06-2003	Serbinis et al.	707/203
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.